VDE | UL | CSA | SETI | SEMKO | DEMKO | NEMKO | BABT

6-Pin DIP Optoisolators Logic Output

H11L1*
[IF(on) = 1.6 mA Max]
H11L2
[IF(on) = 10 mA Max]
*Motorola Preferred Device
STYLE 5 PLASTIC

The H11L1 and H11L2 have a gallium arsenide IRED optically coupled to a high-speed integrated detector with Schmitt trigger output. Designed for applications requiring electrical isolation, fast response time, noise immunity and digital logic compatibility.

- Guaranteed Switching Times — t_{on}, t_{off} < 4 µs
- Built-In On/Off Threshold Hysteresis
- High Data Rate, 1 MHz Typical (NRZ)
- Wide Supply Voltage Capability
- Microprocessor Compatible Drive

Applications

- Interfacing Computer Terminals to Peripheral Equipment
- Digital Control of Power Supplies
- Line Receiver — Eliminates Noise
- Digital Control of Motors and Other Servo Machine Applications
- Logic to Logic Isolator
- Logic Level Shifter — Couples TTL to CMOS

STANDARD THRU HOLE
CASE 730A-04

"T" LEADFORM
WIDE SPACED 0.4"
CASE 730D-05

"S"/"F" LEADFORM
SURFACE MOUNT
CASE 730C-04
(STANDARD PROFILE)

CASE 730F-04
(LOW PROFILE)

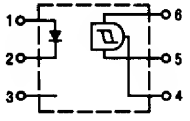
MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
INPUT LED			
Reverse Voltage	V_R	6	Volts
Forward Current — Continuous — Peak Pulse Width = 300 µs, 2% Duty Cycle	I_F	60 1.2	mA Amp
LED Power Dissipation @ T_A = 25°C Derate above 25°C	P_D	120 1.41	mW mW/°C
OUTPUT DETECTOR			
Output Voltage Range	V_O	0–16	Volts
Supply Voltage Range	V_{CC}	3–16	Volts
Output Current	I_O	50	mA
Detector Power Dissipation @ T_A = 25°C Derate above 25°C	P_D	150 1.76	mW mW/°C
TOTAL DEVICE			
Total Device Dissipation @ T_A = 25°C Derate above 25°C	P_D	250 2.94	mW mW/°C
Maximum Operating Temperature (2)	T_A	−40 to +85	°C
Storage Temperature Range	T_{stg}	−55 to +150	°C
Soldering Temperature (10 s)	T_L	260	°C
Isolation Surge Voltage (Pk ac Voltage, 60 Hz, 1 Second Duration) (1)	V_{ISO}	7500	Volts

(1) Isolation surge voltage is an internal device dielectric breakdown rating. For this test, Pins 1 and 2 are common, and Pins 4, 5 and 6 are common.

(2) Refer to Quality and Reliability Section for test information.

SCHEMATIC



PIN 1. ANODE
2. CATHODE
3. V_D
4. GROUND
5. V_{CC}

ELECTRICAL CHARACTERISTICS (T_A = 0 to 70°C)

Characteristic		Symbol	Min	Typ	Max	Unit
Reverse Leakage Current (V_R = 5 V, R_L = 1 MΩ)		I_R	—	0.05	10	μA
Forward Voltage (I_F = 10 mA) (I_F = 0.3 mA)		V_F	— 0.75	1.2 0.95	1.5 —	Volts
Capacitance (V_R = 0 V, f = 1 MHz)		C	—	18	—	pF
OUTPUT DETECTOR						
Operating Voltage		V_{CC}	3	—	15	Volts
Supply Current (I_F = 0, V_{CC} = 5 V)		$I_{CC(off)}$	—	1	5	mA
Output Current, High (I_F = 0, V_{CC} = V_o = 15 V)		I_{OH}	—	—	100	μA
COUPLED						
Supply Current (I_F = $I_{F(on)}$, V_{CC} = 5 V)		$I_{CC(on)}$	—	1.6	5	mA
Output Voltage, Low (R_L = 270 Ω, V_{CC} = 5 V, I_F = $I_{F(on)}$)		V_{OL}	—	0.2	0.4	Volts
Threshold Current, ON (R_L = 270 Ω, V_{CC} = 5 V)	H11L1 H11L2	$I_{F(on)}$	— —	1 —	1.6 10	mA
Threshold Current, OFF (R_L = 270 Ω, V_{CC} = 5 V)	H11L1 H11L2	$I_{F(off)}$	0.3 0.3	0.75 —	— —	mA
Hysteresis Ratio (R_L = 270 Ω, V_{CC} = 5 V)		$\frac{I_{F(off)}}{I_{F(on)}}$	0.5	0.75	0.9	
Isolation Voltage (1) 60 Hz, AC Peak, 1 second, T_A = 25°C		V_{ISO}	7500	—	—	Vac(pk)
Turn-On Time	R_L = 270 Ω V_{CC} = 5 V, I_F = $I_{F(on)}$ T_A = 25°C	t_{on}	—	1.2	4	μs
Fall Time		t_f	—	0.1	—	
Turn-Off Time		t_{off}	—	1.2	4	
Rise Time		t_r	—	0.1	—	

(1) For this test IRED Pins 1 and 2 are common and Output Gate Pins 4, 5, 6 are common.

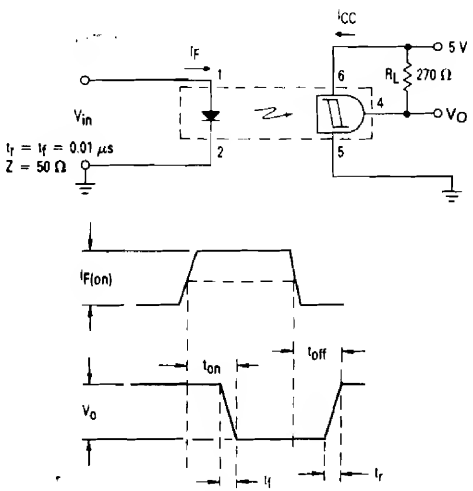


Figure 1. Switching Test Circuit

TYPICAL CHARACTERISTICS

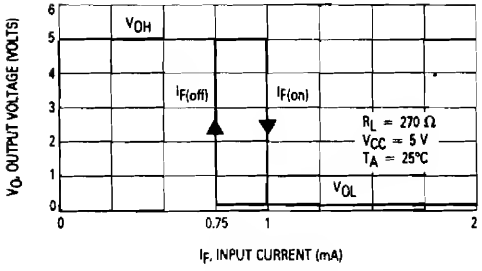


Figure 2. Transfer Characteristics for H11L1

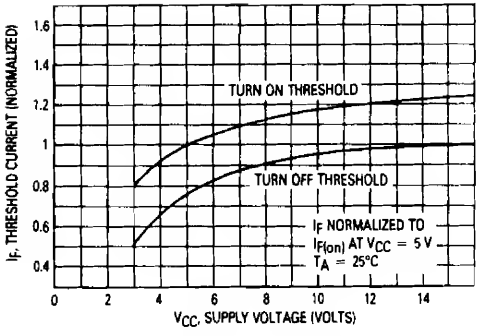


Figure 3. Threshold Current versus Supply Voltage

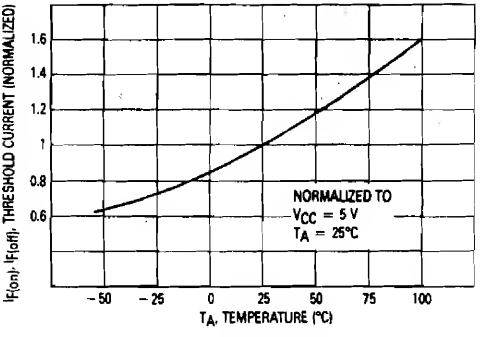


Figure 4. Threshold Current versus Temperature

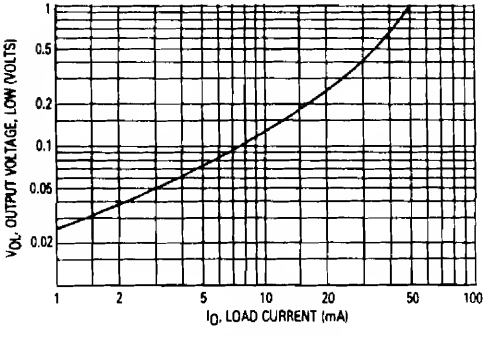


Figure 5. Output Voltage, Low versus Load Current

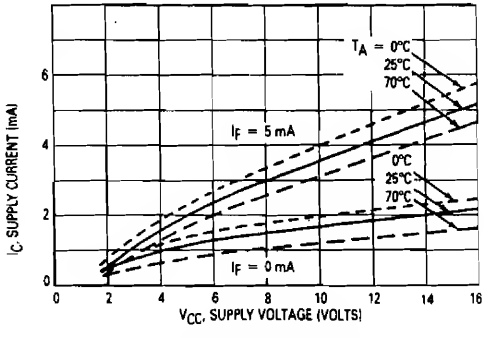


Figure 6. Supply Current versus Supply Voltage